Power MOSFET

80 V, 2.2 A, Dual N-Channel, SO-8

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Dual SO-8 Surface Mount Package Saves Board Space
- This is a Pb-Free Device

Applications

• LCD Displays

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Rating			Symbol	Value	Unit	
Drain-to-Source Voltage			V_{DSS}	80	V	
Gate-to-Source Voltage - Continuous			V_{GS}	±15	V	
Continuous Drain		T _A = 25°C	I _D	1.4	Α	
Current R _{θJA} (Note 1)		T _A = 70°C		1.2		
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	1.0	W	
Continuous Drain	Steady	T _A = 25°C	I _D	1.1	Α	
Current R _{0JA} (Note 2)	State	T _A = 70°C	1	0.9		
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	P _D	0.6	W	
Continuous Drain]	T _A = 25°C	I _D	2.2	Α	
Current $R_{\theta JA}$ t < 5 s (Note 1)		T _A = 70°C		1.7		
Pulsed Drain Current	T _A = 25°C, t _p = 10 μs		I _{DM}	9.0	Α	
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to +150	°C	
Source Current (Body Diode)			I _S	1.3	Α	
Single Pulse Drain-to-Source Avalanche Energy T_J = 25C, V_{DD} = 50 V, V_{GS} = 10 V, I_L = 7.0 A_{pk} , L = 1.0 mH, R_G = 25 Ω			EAS	25	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	ç	

THERMAL RESISTANCE RATINGS

Rating	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	120	
Junction-to-Ambient – t≤ 5 s (Note 1)	$R_{\theta JA}$	48	°C/W
Junction-to-FOOT (Drain)	$R_{\theta JF}$	40	-0/00
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	200	

- 1. Surface-mounted on 2 inch sq FR4 board using 1 inch sq pad size, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.

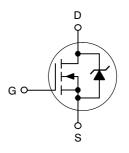


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} Max	I _D Max	
80 V	215 m Ω @ 10 V	22A	
00 V	245 mΩ @ 4.5 V		

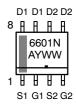
N-Channel



MARKING DIAGRAM & PIN ASSIGNMENT



SO-8 CASE 751 STYLE 11



6601N = Device Code

= Assembly Location= Year

WW = Work Week
■ Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMD6601NR2G	SO-8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				-	-	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				99.8		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 80 V	T _J = 25°C T _J = 125°C			1.0 25	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 15 \text{ V}$				±100	nA
ON CHARACTERISTICS (Note 3)	466	50 7			<u>I</u>		I
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{\Gamma}$	s = 250 µA	1.0	1.9	3.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	103 103,11	, =====================================		4.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.2 A		190	215	mΩ
	= 5(0)	V _{GS} = 5.0 V	I _D = 1.0 A		215	245	
CHARGES, CAPACITANCES AND GAT	E RESISTANCE	•			•	•	•
Input Capacitance	C _{ISS}				220	400	
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1.0 N	MHz, V _{DS} = 25 V		55	100	pF
Reverse Transfer Capacitance	C _{RSS}	, do 1 / 1 / 20			16	30	1 .
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 5.0 V, V _{DS} = 40 V, I _D = 1.0 A			5.0	9.0	
Threshold Gate Charge	Q _{G(TH)}				0.4		nC
Gate-to-Source Charge	Q _{GS}				1.0		
Gate-to-Drain Charge	Q_{GD}				2.75		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 40 V, I _D = 1.0 A			9.0	15	nC
SWITCHING CHARACTERISTICS (Note	4)						
Turn-On Delay Time	t _{d(ON)}				21	35	
Rise Time	t _r	V _{GS} = 4.5 V, V _{DD} = 40 V,			62	105	1 ,,
Turn-Off Delay Time	t _{d(OFF)}	I _D = 1.0 A, R	$G = 27 \Omega$		52	85	ns
Fall Time	t _f				50	85	1
Turn-On Delay Time	t _{d(ON)}				15		
Rise Time	t _r	V_{GS} = 10 V, V_{DD} = 40 V, I_{D} = 2.5 A, R_{G} = 47 Ω			95		ns
Turn-Off Delay Time	t _{d(OFF)}				50		110
Fall Time	t _f				105		
BODY - DRAIN DIODE RATINGS (Note	3)						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V	T _J = 25°C		0.8	1.0	V
		I _D = 1.0 A	T _J = 150°C	0.6			
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, d_{IS}/d_t = 100 A/ μ s, I_S = 1.0 A			44		ns
Charge Time	T _a				21] ''
Discharge Time	T _b				23		
Reverse Recovery Time	Q _{RR}				43	86	nC

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL ELECTRICAL CHARACTERISTICS

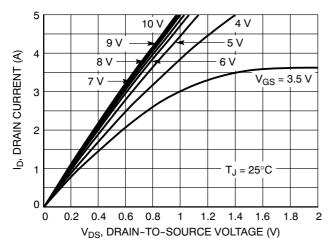


Figure 1. On-Region Characteristics

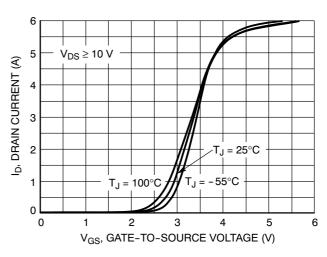


Figure 2. Transfer Characteristics

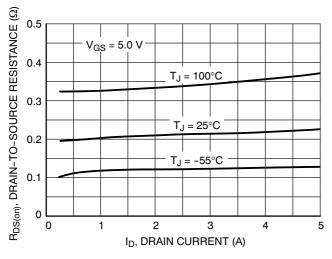


Figure 3. On-Resistance versus Drain Current and Temperature

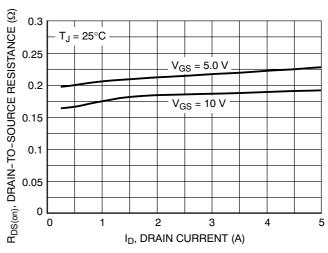


Figure 4. On-Resistance versus Drain Current and Gate Voltage

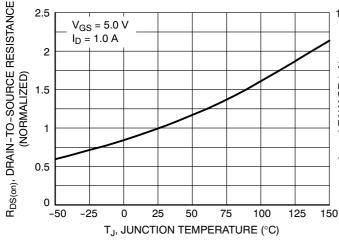


Figure 5. On–Resistance Variation with Temperature

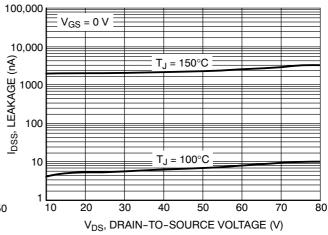
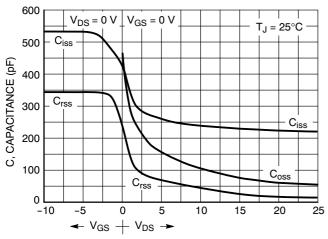


Figure 6. Drain-To-Source Leakage Current versus Voltage

TYPICAL ELECTRICAL CHARACTERISTICS



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

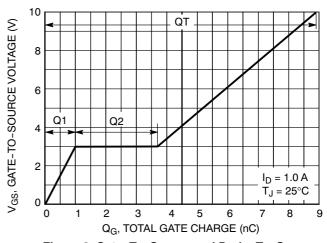


Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

Figure 7. Capacitance Variation

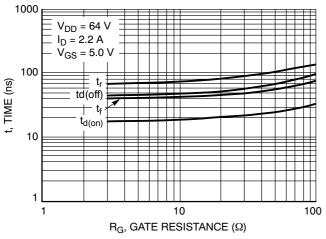


Figure 9. Resistive Switching Time Variation versus Gate Resistance

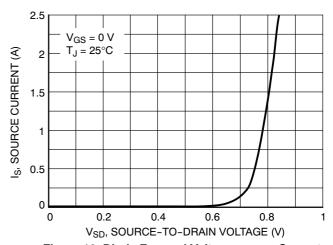


Figure 10. Diode Forward Voltage versus Current

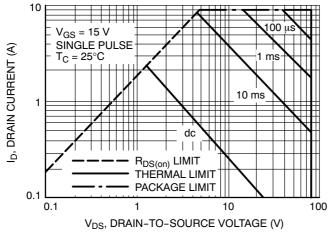


Figure 11. Maximum Rated Forward Biased Safe Operating Area

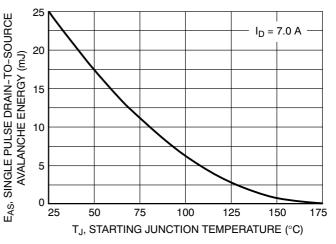


Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

TYPICAL ELECTRICAL CHARACTERISTICS

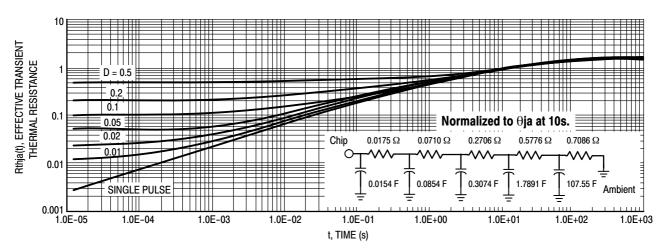


Figure 13. Thermal Response

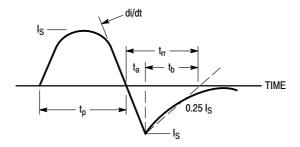
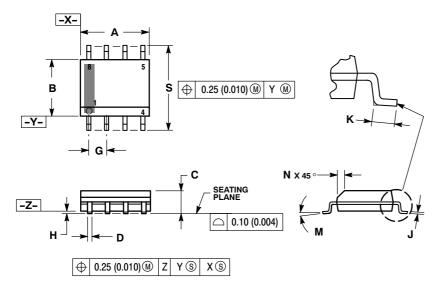


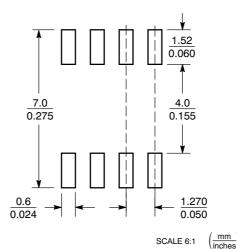
Figure 14. Diode Reverse Recovery Waveform

PACKAGE DIMENSIONS

SO-8 NB CASE 751-07 **ISSUE AJ**



SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
 DIMENSION A AND B DO NOT INCLUDE
- MOLD PROTRUSION
- 4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

	MILLIN	IETERS	INC	INCHES		
DIM	MIN	MIN MAX		MAX		
Α	4.80	5.00	0.189	0.197		
В	3.80	4.00	0.150	0.157		
С	1.35	1.75	0.053	0.069		
D	0.33	0.51	0.013	0.020		
G	1.27	1.27 BSC		0.050 BSC		
Н	0.10	0.25	0.004	0.010		
J	0.19	0.25	0.007	0.010		
K	0.40	1.27	0.016	0.050		
M	0 °	8 °	0 °	8 °		
N	0.25	0.50	0.010	0.020		
S	5.80	6.20	0.228	0.244		

STYLE 11:

- PIN 1. SOURCE 1
 - 2. GATE 1
 - SOURCE 2 3.
 - GATE 2 5 DRAIN 2
 - DRAIN 2 6.
 - DRAIN 1
 - DRAIN 1

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